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NO. 6514 P. 1/2

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Jean M. Dickman

TO  
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FROM  
JEAN M. DICKMAN

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2 Pages Transmitted

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PTOL-413A (06-07)  
Approved for use through 08/30/2007. OMB 0651-0031  
U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

## Applicant Initiated Interview Request Form

Application No.: 10/751,292  
Examiner: Karlheinz R. SkowronekFirst Named Applicant: Mark A. Hoffman  
Art Unit: 1631 Status of Application: Pending

## Tentative Participants:

(1) Karlheinz R. Skowronek, Examiner (2) Jean M. Dickman  
(3) Peter J. Hoeller (4)

Proposed Date of Interview: Monday, June 18, 2007

Proposed Time: 3:00 E.S.T. P.M.

## Type of Interview Requested:

(1) [X] Telephonic (2) [ ] Personal (3) [ ] Video Conference

Exhibit To Be Shown or Demonstrated: [ ] YES

[ ] NO

If yes, provide brief description:

## Issues To Be Discussed

Issues (Rej., Obj., etc)	Claims/ Fig. #s	Prior Art	Discussed	Agreed	Not Agreed
(1) Rej.	32-52	Multiple Cited References	[ ]	[ ]	[ ]
(2)			[ ]	[ ]	[ ]
(3)			[ ]	[ ]	[ ]
(4)			[ ]	[ ]	[ ]
[ ] Continuation Sheet Attached					

## Brief Description of Arguments to be Presented:

Discuss differences between claims 32-52 and the cited references.

An interview was conducted on the above-identified application on \_\_\_\_\_.

NOTE: This form should be completed by applicant and submitted to the examiner in advance of the interview (see MPEP § 713.01).

This application will not be delayed from issue because of applicant's failure to submit a written record of this interview. Therefore, applicant is advised to file a statement of the substance of this interview (37 CFR 1.133(b)) as soon as possible.

/Jean M. Dickman/

Applicant/Applicant's Representative Signature  
Jean M. Dickman

Examiner/SPE Signature

Typed/Printed Name of Applicant or Representative

46,538

Registration Number, if applicable

This collection of information is required by 37 CFR 1.133. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.11 and 1.14. This collection is estimated to take 21 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

If you need assistance in completing the form, call 1-800-PTO-9199 and select option 2.